Power Supply Regulation Systems Installed in the Fermilab Accelerators

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POWER SUPPLY REGULATION SYSTEMS INSTALLED IN THE FERMILAB ACCELERATORS

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Abstract

A variety of current and voltage regulation systems have been installed in the Fermilab large magnet system. The four major systems employ different methods to achieve the desired degree of regulation. The methods include computer control and feedback, adaptive "learning, precision (10ppm) current monitoring, and the use of feed-forward signals. This paper will explain each method used and present the measured regulation of the above systems. Also an overview of planned upgrades and improvements will be presented.

INTRODUCTION

The need for higher resolution and stability in power supply current regulation is becoming more necessary for accelerator physics. One step to developing new and better systems is to understand the limitation of the existing types now in operation. There are four different regulation system types installed in Fermilab's two main accelerators. They all have the same goal of current regulation but each has its own unique load and tracking requirement which has stimulated the need for the different types of control. The Tevatron regulation system controls the four mile Tevatron superconducting magnet string; the Main Ring system controls the four mile conventional magnet strings; the Low Beta systems control the Tevatron interaction regions magnets; and the Overpass systems control the magnets that bypass the main ring proton beam around the Tevatron interaction regions.

TEVATRON REGULATION

The FERMILAB Tevatron power supply system consists of 12 distributed voltage regulated, 850 volt power supplies connected to a 37 Henry load. Ten of the voltage regulated supplies are 2.8 MVA each, and are used as ramping voltage sources. The other two are 5 MVA supplies of which one is used as a regulator, the other for ramping. This system ramps from 400 to 4400 amps over a 60 second cycle in fixed target mode or holds at 4400 amps for up to 18 hours in collider operation.

The current regulation system starts with a ramp generating computer, which provides the feedforward voltage waveforms to the 12 power supplies. The ramp generating computer also provides a current reference waveform to a temperature regulated "24 bit" Digital to Analog converter. This "24 bit" DAC is constructed using an ultra stable ANALOGIC 16 bit DAC combined with an 8 bit DAC, which theoretically yields the 24 bits. This high resolution is desired to minimize the size of the voltage steps out of the regulating power supply during ramping. The combined DAC output and the current signal from a temperature regulated D.C. Current Transformer (DCCT) are subtracted to generate the "current error signal" which is sent to the regulating power supply in an analog format. This signal is used to close a real time feedback loop with a bandwidth of 10 Hz. Both the DAC and the burden resistor of the DCCT are temperature regulated in an oven operating at 38°C.

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MEASUREMENTS

Measurements on the 24 bit DAC have shown a maximum resolution of 21 bits: the lower three bit are masked by the noise level of the electronics. The 21 bit capability represents a resolution of 0.5 ppm.

Current measurements made during 800 GeV operation (3550 amps) are shown below where the full scale corrective waveform is shown below where the full scale corrective waveform that learns from one machine cycle and corrects the next. This technique extends the bandwidth of the system, and enables it to regulate rapidly changing current waveforms.

Ripple currents at 3550 amps:
- Measurement bandwidth:
  - 3KHz: ± 5 ppm of F.S.
  - 300Hz: ± 2 ppm of F.S.
  - 30Hz: ± 1.25 ppm of F.S.

These numbers are on the order of the inherent transducer noise.

Ramp-to-Ramp Variation at 3550 flattop:
- 15Hz Measurement bandwidth: ± .3 ppm of F.S.

Long Term Drift:
The DC current during collider mode operation was measured periodically over a three months using a second DCCT and was found to have a stability of:
- ± 5 ppm of F.S.

Tracking of the Ramp Reference:
- 15Hz Measurement bandwidth: ± 20 ppm of F.S.

Absolute Current Accuracy: ± .1%
The absolute accuracy of the current regulation systems have not been of large concern to operation. The beam position is controlled by small correction devices and tends to be empirically tuned.

MAIN RING SYSTEM

The Fermilab Main Ring power supply system consist of twenty five 2.8 MVA voltage regulated power supplies on the bend bus and eleven 2.8 MVA supplies on the two quad buses. Regulation is controlled by two task sharing computers which have control of a 35 supplies over a serial link running at 10 Mega bits/second. These computers generate feedforward voltage waveforms and control current references much like the Tevatron computer. The feedforward control of the twenty four bend bus supplies is divided into four groups of six supplied which are ramped in sequence rather than all together. This method is a compromise involving consideration of reactive power, low current ripple and passive filter characteristics. The power supply voltage reference update rate is 720 Hz.

The computers send the bend bus current reference waveform to a 16 bit ANALOG DEVICES DAC. The signal from a 5,000 amp HOLEC DCCT is subtracted from the DAC output and amplified to generate an error signal. This signal is read by the computers which use it to provide adaptive correction to all of the supplies and direct feedback to the regulator. The adaptive correction consist of using the error signal to form a corrective waveform that learns from one machine cycle and corrects the next. This technique extends the bandwidth of the system, and enables it to regulate rapidly changing current waveforms.

The two Quadropole buses each run at = 92% of the bend bus and are regulated using 300 amp transducers that measure the difference between each quad bus current and the bend bus current. This is accomplished by using a coaxial bus arrangement with the quadropole and bend currents flowing in opposite directions through the transducer head.

MEASUREMENTS

The Main Ring is ramped to two different levels: 120 Gev level (1350 amps) with a 2.4 second cycle for antiproton production and 150 Gev level (1700 amps) with a 54 second cycle for Tevatron injection. The injection level from the booster accelerator is 8 Gev (90 amps).

Regulation at injection: 90 amps
- 720Hz Measurement bandwidth:
  - Bend Bus: ± 300 ppm
  - Quad Vertical Bus: ± 200 ppm
  - Quad Horizontal Bus: ± 370 ppm

Regulation at 120 Gev Flattop: 1350 amps
- 720Hz Measurement bandwidth:
  - Bend Bus: ± 40 ppm
  - Quad Vertical Bus: ± 60 ppm
  - Quad Horizontal Bus: ± 44 ppm

Regulation at 150 Gev Flattop: 1700 amps
- 720Hz Measurement bandwidth:
  - Bend Bus: ± 60 ppm

Tracking during ramping:
- 720Hz Measurement bandwidth:
  - Bend Bus: Through Flattop ± 80 ppm
  - Including invert ± 450 ppm

Absolute Current Accuracy
± .01% of reading (HOLEC Transductor Spec.)
LOW BETA SYSTEM

This 10ppm regulation system was constructed to be used on ramping superconducting magnet loads but is applicable to conventional magnet power systems. The system consists of a commercial 10ppm transducer used to measure the magnet current and then provide the necessary feedback signals to close a current loop around a voltage regulated supply. This system is intended to be used as a stand alone package connected to a 1% voltage regulated power supply. The transducer electronics, DAC reference and subtraction electronics, as now installed, use a temperature regulated water cooler and circulation pump to provide a constant temperature environment. The water cooling is provided by a stand alone, cool only refrigeration circuit system manufactured by NESTLAB. This system was installed as an upgrade to existing power supplies with the goal to provide a standard package for use in many applications and lower the need for unique spare parts for each supply.

Magnet load compensation is provided for in the regulator and includes Proportional plus Derivative (PD) feedforward signals if needed for faster ramping devices. Additional features provided are slow start, over current detection, out of regulation beam abort signals and local voltage mode control for testing.

To provide the most accurate reference signal, the current reference is received by the regulator on a 16 bit strobed data bus. To provide slew rate limiting without introducing additional errors, the digital reference data lines are intercepted and the slew rate function is performed by a single chip microcontroller before the data is sent to the DAC module. This microcontroller also provides local current or open loop voltage reference control and has a built-in ramp generator for local testing.

The current regulator is packaged in a 3U high 19” rack sub rack with modular cards and plug-in units for ease of maintenance and repair. The 10 ppm transducers used are also 19” rack mounted manufactured by either HOLEC or DANFYSIK. There are five independent regulation loops installed in each of the interaction regions which all share the one local water system.

The DAC module contains a 16 bit ANALOGIC MP-8116-1 Digital to Analog converter and the accurate subtraction circuits necessary for regulation. This module also provides high quality output to the rear panel for monitoring the current and reference signals during operation. These monitors are used in the FNAL system with a 6½ digit DATRON meter connected to a CAMAC based IEEE-488 interface for data logging in the main control room.

With a secondary goal of constructing a “standard package” current regulation system, two types of 42 HP DAC modules have been constructed. One which uses chilled water and an external closed loop water system for use when there is more than one installed in a single location and the second uses a thermoelectric cooler for single loop operation.

GAIN LOWERING CIRCUIT

Four of the Low Beta Quad power supplies, for which these current regulators were built, have reversing switches installed. The reversing switches require a ramp to zero current for switching and during this time the supply must remain stable but the regulation need not be as accurate. The nonlinearity as a result of the switch S.C.R.s cause a low current loop instability. We have chosen to use gain adjustment based on reference levels in order to maintain stability. When the reference level ramps below 100 amps the current loop gain is ramped down by a factor of 5 and ramps back up when the reference exceeds 50 amps after the switching.

MEASUREMENTS

The long term measurements were made using the IEEE-488 interface and DATRON meter connected to a data logger. The ramped data was taken during fixed target operation using a Tek AM502 differential amplifier with a selectively adjustable bandwidth. The full scale below (F.S.) represents 7,500 amps.

Regulation at injection: 216 amps
- 15 Measurement bandwidth ± 2 ppm of F.S.
- 120 Hz ripple current ± 3 ppm of F.S.

Drift during 20 hr. store: 216 amps
- @ 150 Gev injection ± 3 ppm of F.S.

800 Gev ramping: 1160 amps
- 100 Hz Measurement bandwidth
  - Flattop ± 1.5 ppm of F.S.
  - Ramp up ± 50 ppm of F.S.
  - Ramp down ± 130 ppm of F.S.

Ramp to Ramp variation: ± .3 ppm of F.S.

OVERPASS SYSTEM

The Main Ring beam path moves above the collider detectors at two locations in the accelerator. This move requires vertical bends as well as a higher radial bend inward. The inward bend is required to keep the path length the beam has to travel around the accelerator the same as the original design. The vertical bending magnets and an equal number of horizontal bending
A bandwidth of 100 Hz.

Regulation at injection: 180 amps ± 556 ppm

Regulation at 120
Gev Flattop: 2700 amps ± 74 ppm

Regulation at 150
Gev Flattop: 3400 amps ± 75 ppm

Ramp up
Ramp down ± 150 ppm ± 520 ppm

**IMPROVEMENTS**

Planed improvements to the Main Ring system include the replacement of the existing adaptive control computers with 68040 VME based computers. This new system will use a processor for each bus and will include a circular buffer for recording many of the control and monitoring signals. As part of this upgrade eight new 10ppm transductors and a 10ppm current regulator of the type described above will be installed.

An additional improvement to the power supply systems will be to standardize the voltage regulators. The present maintenance load require by the many different power supplies which each have a unique regulation system, is large in both manpower and spare parts. The voltage regulator will have available voltage monitors, filter compensation, DAC and analog reference inputs, fast bypass failure checking and a serial link interface for multiple supply control.

**REFERENCES**

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**MEASUREMENTS**

The following measurements were made during ramping using a Tektronix Am502 differential amplifier set to

- magnets run at twice the main ring current (3,400 amps). This bending field must track the main ring field to 0.1%, because the RF system corrects for momentum errors during the ramp at only one physical location.

- The tracking method used is to install three transducers, one on the main ring bus, one on the bus to be regulated and the third used to subtract the burden resistor currents of the first two. Using a turns ratio of 14.7 wound on the core of the third 10 amp transductor allowed for the subtraction and gain adjust without adding more drift components into the regulation loop. The main ring transductor is also used to provide a current reference to the system. This reference is used to generate and provide a feedforward signal for the power supply.

\[ V_{output} = IR + L \frac{di}{dt} + K \frac{d^2i}{dt^2} \]

A small correction program injected to allow the Main Control Room to offset the overpass current in order to adjust the position of the main ring beam.

\[ V = I R + L \frac{di}{dt} + K \frac{d^2i}{dt^2} \]